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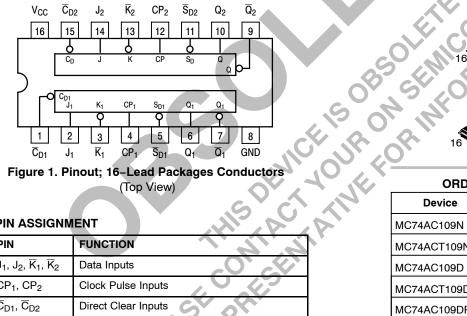
Dual JK Positive Edge-Triggered Flip-Flop

The MC74AC109/74ACT109 consists of two high-speed completely independent transition clocked $J\overline{K}$ flip-flops. The clocking operation is independent of rise and fall times of the clock waveform. The JK design allows operation as a D flip-flop (refer to MC74AC74/74ACT74 data sheet) by connecting the J and \overline{K} inputs together.

Asynchronous Inputs:

LOW input to \overline{S}_D (Set) sets Q to HIGH level LOW input to \overline{C}_D (Clear) sets Q to LOW level Clear and Set are independent of clock Simultaneous LOW on \overline{C}_D and \overline{S}_D makes both Q and \overline{Q} HIGH

- Outputs Source/Sink 24 mA
- 'ACT109 Has TTL Compatible Inputs





PIN ASSIGNMENT

PIN	FUNCTION
$J_1, J_2, \overline{K}_1, \overline{K}_2$	Data Inputs
CP ₁ , CP ₂	Clock Pulse Inputs
$\overline{C}_{D1}, \overline{C}_{D2}$	Direct Clear Inputs
$\overline{S}_{D1}, \overline{S}_{D2}$	Direct Set Inputs
$\begin{array}{c} Q_1, Q_2, \overline{Q}_1, \ \overline{Q}_2 \end{array}$	Outputs



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N SUFFIX CASE 648

DIP-16

SO-16 **D SUFFIX** CASE 751B

TSSOP-16 DT SUFFIX CASE 948F

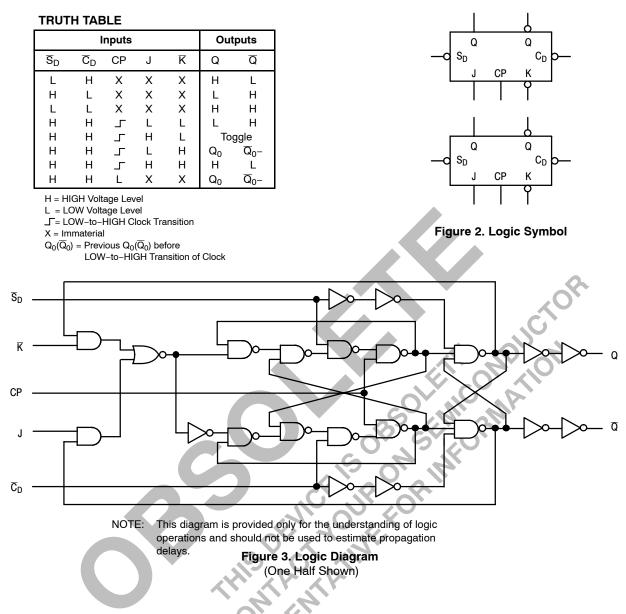
EIAJ-16 **M SUFFIX CASE 966**

ORDERING INFORMATION

Device	Package	Shipping
MC74AC109N	PDIP-16	25 Units/Rail
MC74ACT109N	PDIP-16	25 Units/Rail
MC74AC109D	SOIC-16	48 Units/Rail
MC74ACT109D	SOIC-16	48 Units/Rail
MC74AC109DR2	SOIC-16	2500 Tape & Reel
MC74ACT109DR2	SOIC-16	2500 Tape & Reel
MC74AC109DT	TSSOP-16	96 Units/Rail
MC74ACT109DT	TSSOP-16	96 Units/Rail
MC74AC109DTR2	TSSOP-16	2500 Tape & Reel
MC74ACT109DTR2	TSSOP-16	2500 Tape & Reel
MC74AC109M	EIAJ-16	50 Units/Rail
MC74ACT109M	EIAJ-16	50 Units/Rail
MC74AC109MEL	EIAJ-16	2000 Tape & Reel
MC74ACT109MEL	EIAJ-16	2000 Tape & Reel

DEVICE MARKING INFORMATION

See general marking information in the device marking section on page 6 of this data sheet.



MAXIMUM RATINGS*

Symbol	Parameter	Value	Unit
V _{CC}	DC Supply Voltage (Referenced to GND)	–0.5 to +7.0	V
V _{IN}	DC Input Voltage (Referenced to GND)	–0.5 to V _{CC} +0.5	V
V _{OUT}	DC Output Voltage (Referenced to GND)	–0.5 to V _{CC} +0.5	V
I _{IN}	DC Input Current, per Pin	±20	mA
I _{OUT}	DC Output Sink/Source Current, per Pin	±50	mA
I _{CC}	DC V _{CC} or GND Current per Output Pin	±50	mA
T _{stg}	Storage Temperature	-65 to +150	°C

*Maximum Ratings are those values beyond which damage to the device may occur. Functional operation should be restricted to the Recommended Operating Conditions.

RECOMMENDED OPERATING CONDITIONS

Symbol	Parameter		Min	Тур	Max	Unit
		'AC	2.0	5.0	6.0	
V _{CC}	Supply Voltage	'ACT	4.5	5.0	5.5	V
V _{IN} , V _{OUT}	DC Input Voltage, Output Voltage (Ref. to GND)		0	-	V _{CC}	V
		V _{CC} @ 3.0 V	-	150	-	
t _r , t _f	, t _f Input Rise and Fall Time (Note 1) 'AC Devices except Schmitt Inputs	V _{CC} @ 4.5 V	-	40	-	ns/V
		V _{CC} @ 5.5 V	-	25	-	
	Input Rise and Fall Time (Note 2)	V _{CC} @ 4.5 V	-	10	-	
t _r , t _f	'ACT Devices except Schmitt Inputs	V _{CC} @ 5.5 V	-	8.0	-	ns/V
TJ	Junction Temperature (PDIP)		-	_	140	°C
T _A	Operating Ambient Temperature Range	-40	25	85	°C	
I _{OH}	Output Current – High			-	-24	mA
I _{OL}	Output Current – Low			-	24	mA

.

1. V_{IN} from 30% to 70% V_{CC} ; see individual Data Sheets for devices that differ from the typical input rise and fall times. 2. V_{IN} from 0.8 V to 2.0 V; see individual Data Sheets for devices that differ from the typical input rise and fall times.

DC CHARACTERISTIC	S
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			74	AC	74AC		8
Symbol	Parameter	V _{CC} (V)	T _A = +25°C		T _A = −40°C to +85°C	Unit	Conditions
			Тур	Guar	anteed Limits		
V _{IH}	Minimum High Level Input Voltage	3.0 4.5 5.5	1.5 2.25 2.75	2.1 3.15 3.85	2.1 3.15 3.85	V	$V_{OUT} = 0.1 V$ or $V_{CC} - 0.1 V$
V _{IL}	Maximum Low Level Input Voltage	3.0 4.5 5.5	1.5 2.25 2.75	0.9 1.35 1.65	0.9 1.35 1.65	V	$V_{OUT} = 0.1 V$ or $V_{CC} - 0.1 V$
V _{OH}	Minimum High Level Output Voltage	3.0 4.5 5.5	2.99 4.49 5.49	2.9 4.4 5.4	2.9 4.4 5.4	V	I _{OUT} = -50 μA
	Output Voltage	3.0 4.5 5.5		2.56 3.86 4.86	2.46 3.76 4.76	V	$V_{IN} = V_{IL} \text{ or } V_{IH}$ -12 mA I_{OH} -24 mA -24 mA
V _{OL}	Maximum Low Level Output Voltage	3.0 4.5 5.5	0.002 0.001 0.001	0.1 0.1 0.1	0.1 0.1 0.1	V	I _{OUT} = 50 μA
	Photo Ki	3.0 4.5 5.5	- -	0.36 0.36 0.36	0.44 0.44 0.44	V	*V _{IN} = V _{IL} or V _{IH} 12 mA I _{OL} 24 mA 24 mA
I _{IN}	Maximum Input Leakage Current	5.5	-	±0.1	±1.0	μΑ	$V_{I} = V_{CC}, \text{ GND}$
I _{OLD}	†Minimum Dynamic	5.5	-	-	75	mA	V _{OLD} = 1.65 V Max
I _{OHD}	Output Current	5.5	-	-	-75	mA	V _{OHD} = 3.85 V Min
Icc	Maximum Quiescent Supply Current	5.5	-	4.0	40	μA	$V_{IN} = V_{CC}$ or GND

*All outputs loaded; thresholds on input associated with output under test.

†Maximum test duration 2.0 ms, one output loaded at a time.

NOTE: I_{IN} and I_{CC} @ 3.0 V are guaranteed to be less than or equal to the respective limit @ 5.5 V V_{CC}.

AC CHARACTERISTICS (For Figures and Waveforms - See Section 3 of the ON Semiconductor FACT Data Book, DL138/D)

				74AC		74	AC		
Symbol	Parameter	V _{CC} * (V)	T _A = +25°C C _L = 50 pF			T _A = -40°C to +85°C C _L = 50 pF		Unit	Fig. No.
			Min	Тур	Max	Min	Max		
f _{max}	Maximum Clock Frequency	3.3 5.0	125 150	-	-	100 125	-	MHz	3–3
t _{PLH}	Propagation Delay CP_n to Q_n or \overline{Q}_n	3.3 5.0	4.0 2.5	-	13.5 10.0	3.5 2.0	16.0 10.5	ns	3–6
t _{PHL}	Propagation Delay CP_n to Q_n or \overline{Q}_n	3.3 5.0	3.0 2.0	-	14.0 10.0	3.0 1.5	14.5 10.5	ns	3–6
t _{PLH}	Propagation Delay \overline{C}_{Dn} or \overline{S}_{Dn} to Q_n or \overline{Q}_n	3.3 5.0	3.0 2.5	-	12.0 9.0	2.5 2.0	13.0 10.0	ns	3–6
t _{PHL}	Propagation Delay $\overline{C}D_n$ or \overline{S}_{Dn} to Q_n or \overline{Q}_n	3.3 5.0	3.0 2.0		12.0 9.5	3.0 2.0	13.5 10.5	ns	3–6
*Voltage Range 3.3 V is 3.3 V ±0.3 V. *Voltage Range 5.0 V is 5.0 V ±0.5 V.									
				7440		74			

AC OPERATING REQUIREMENTS

Symbol	Parameter	V _{CC} * (V)	$T_{A} = +25^{\circ}C$ $C_{L} = 50 \text{ pF}$ Typ Guaranteed		74AC $T_A = -40^{\circ}C$ to +85°C $C_L = 50 \text{ pF}$ d Minimum	Unit	Fig. No.
t _s	Set–up Time, HIGH or LOW J_n or \overline{K}_n to CP_n	3.3 5.0		6.5 4.5	7.5 5.0	ns	3–9
t _h	Hold Time, HIGH or LOW J_n or \overline{K}_n to CP_n	3.3 5.0		0 0.5	0 0.5	ns	3–9
t _w	Pulse Width $CP_{n \text{ or }}\overline{C}_{Dn}$ or \overline{S}_{Dn}	3.3 5.0		4.0 3.5	4.5 3.5	ns	3–6
t _{rec}	Recovery Time \overline{C}_{Dn} or \overline{S}_{Dn} to CP	3.3 5.0		0 0	0 0	ns	3–9
*Voltage Ran	ge 3.3 V is 3.3 V ±0.3 V. ge 5.0 V is 5.0 V ±0.5 V.						
DC CHARA	CTERISTICS				1		1

DC CHARACTERISTICS

			74ACT		74ACT		
Symbol	Parameter	V _{CC} (V)	T _A =	+25°C	T _A = –40°C to +85°C	Unit	Conditions
			Тур	Guar	anteed Limits		
V _{IH}	Minimum High Level Input Voltage	4.5 5.5	1.5 1.5	2.0 2.0	2.0 2.0	V	V_{OUT} = 0.1 V or V _{CC} – 0.1 V
V _{IL}	Maximum Low Level Input Voltage	4.5 5.5	1.5 1.5	0.8 0.8	0.8 0.8	V	V_{OUT} = 0.1 V or V _{CC} – 0.1 V
V _{OH}	Minimum High Level Output Voltage	4.5 5.5	4.49 5.49	4.4 5.4	4.4 5.4	V	l _{OUT} = -50 μA
		4.5 5.5	_	3.86 4.86	3.76 4.76	V	$V_{IN} = V_{IL} \text{ or } V_{IH}$ -24 mA I_{OH} -24 mA

*All outputs loaded; thresholds on input associated with output under test.

†Maximum test duration 2.0 ms, one output loaded at a time.

DC CHARACTERISTICS (continued)

			744	СТ	74ACT		
Symbol	Parameter	V _{CC} (V)	T _A = +25°C		T _A = -40°C to +85°C	Unit	Conditions
			Тур	Guar	anteed Limits		
V _{OL}	Maximum Low Level Output Voltage	4.5 5.5	0.001 0.001	0.1 0.1	0.1 0.1	V	l _{OUT} = 50 μA
		4.5 5.5		0.36 0.36	0.44 0.44	V	$\label{eq:VIN} \begin{array}{c} {}^{*}V_{IN} = V_{IL} \text{ or } V_{IH} \\ 24 \text{ mA} \\ I_{OL} \\ 24 \text{ mA} \end{array}$
I _{IN}	Maximum Input Leakage Current	5.5	-	±0.1	±1.0	μA	$V_{I} = V_{CC}, GND$
ΔI_{CCT}	Additional Max. I _{CC} /Input	5.5	0.6	-	1.5	mA	$V_I = V_{CC} - 2.1 V$
I _{OLD}	†Minimum Dynamic	5.5	-	_	75	mA	V _{OLD} = 1.65 V Max
I _{OHD}	Output Current	5.5	-		-75	mA	V _{OHD} = 3.85 V Min
I _{CC}	Maximum Quiescent Supply Current	5.5	-	4.0	40	μΑ	V _{IN} = V _{CC} or GND

*All outputs loaded; thresholds on input associated with output under test. †Maximum test duration 2.0 ms, one output loaded at a time.

AC CHARACTERISTICS (For Figures and Waveforms - See Section 3 of the ON Semiconductor FACT Data Book, DL138/D)

Symbol	bol Parameter		Т	74ACT A = +25° L = 50 p	C F	744 T _A = - to +8 C _L = 5	-40°C 85°C	Unit	Fig. No.
			Min	Тур	Max	Min	Max		
f _{max}	Maximum Clock Frequency	5.0	145	5-	-	125	-	MHz	3–3
t _{PLH}	Propagation Delay CP_n to Q_n or \overline{Q}_n	5.0	4.0	-	11.0	3.5	13.0	ns	3–6
t _{PHL}	Propagation Delay CP_n to Q_n or \overline{Q}_n	5.0	3.0	-	10.0	2.5	11.5	ns	3–6
t _{PLH}	Propagation Delay \overline{C}_{Dn} or \overline{S}_{Dn} to Q_n or \overline{Q}_n	5.0	2.5	-	9.5	2.0	10.5	ns	3–6
t _{PHL}	Propagation Delay \overline{C}_{Dn} or \overline{S}_{Dn} to Q_n or \overline{Q}_n	5.0	2.5	-	10.0	2.0	11.5	ns	3–6

*Voltage Range 5.0 V is 5.0 V ±0.5 V.

AC OPERATING REQUIREMENTS

	Q *			74ACT	74ACT		
Symbol	Parameter	Parameter V_{CC}^* $T_A = +25^{\circ}C$ (V) $C_L = 50 \text{ pF}$		$ \begin{array}{c} T_{A}=+25^{\circ}C \\ C_{L}=50 \ pF \end{array} \begin{array}{c} T_{A}=-40^{\circ}C \\ to +85^{\circ}C \\ C_{L}=50 \ pF \end{array} $		Unit	Fig. No.
			Тур	Guaranteed	d Minimum		
t _s	Set–up Time, HIGH or LOW J_n or \overline{K}_n to CP_n	5.0	-	2.0	2.5	ns	3–9
t _h	Hold Time, HIGH or LOW $J_n \text{ or } \overline{K}_n \text{ to } CP_n$	5.0	-	2.0	2.0	ns	3–9
t _w	Pulse Width CP _{n or}	5.0	-	5.0	6.0	ns	3–6

*Voltage Range 5.0 V is 5.0 V \pm 0.5 V.

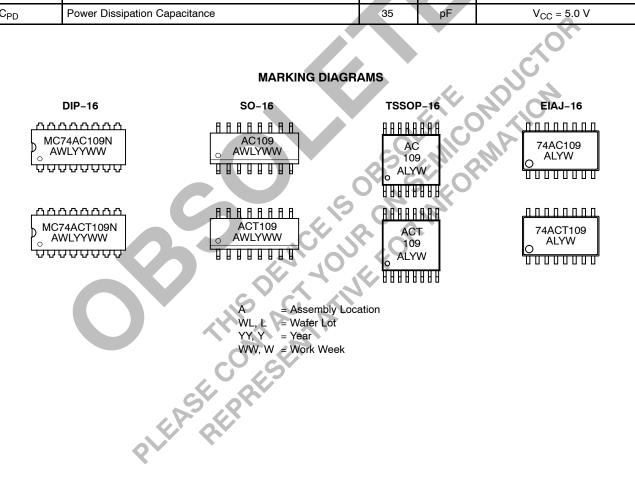
AC OPERATING REQUIREMENTS (continued)

Symbol	Parameter	V _{cc} * (V)	74ACT		74ACT		Fig. No.
			T _A = +25°C C _L = 50 pF		T _A = −40°C to +85°C C _L = 50 pF	Unit	
			Тур	Guaranteed			
t _{rec}	Recovery TIme C _{Dn} or S _{Dn} to CP	5.0	_	0	0	ns	3–9

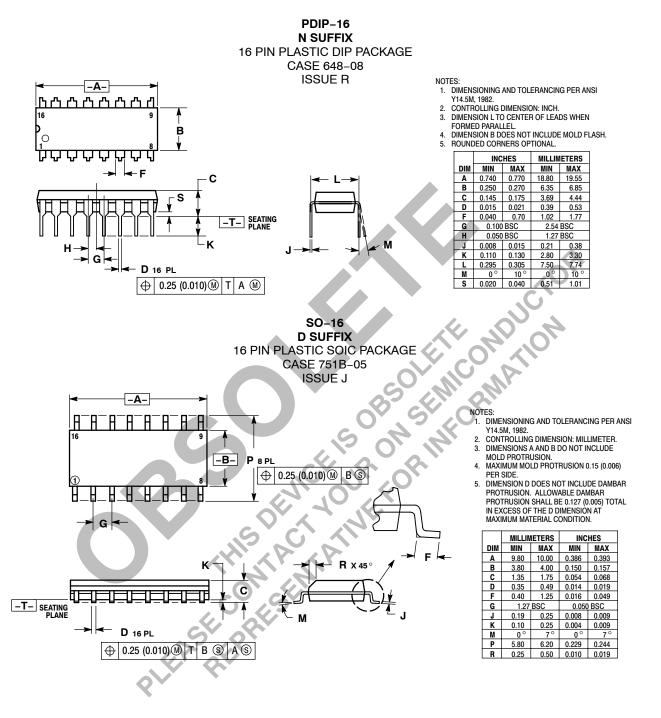
*Voltage Range 5.0 V is 5.0 V ±0.5 V.

CAPACITANCE

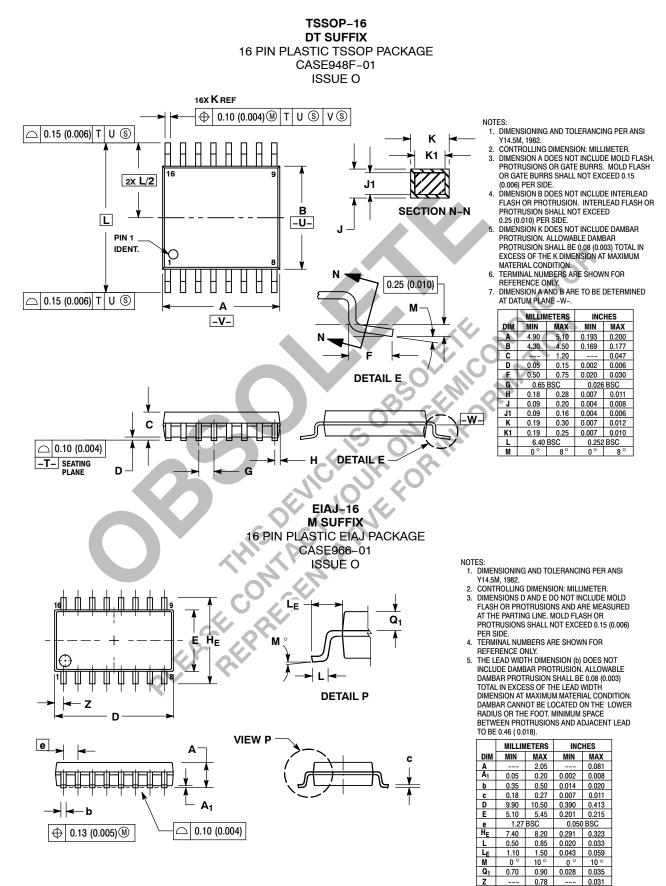
Symbol	Parameter	Value Typ	Unit	Test Conditions
C _{IN}	Input Capacitance	4.5	pF	V _{CC} = 5.0 V
C _{PD}	Power Dissipation Capacitance	35	pF	V _{CC} = 5.0 V



PACKAGE DIMENSIONS



PACKAGE DIMENSIONS





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